

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/682,223	SCHUBERT ET AL.		
Examiner	Art Unit		
Holon O. Chu	1745		

	SEARCHED				
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Class	Subclass	Date	Examiner		
429	57	9/22/2006	нс		
429	174	9/22/2006	нс		
429	188	9/22/2006	нс		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Palm and Edan (Inventor Search)	9/22/2006	НС		
East Search (Notes Included)	9/22/2006	нс		